## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10597232	KONRATH ET AL.
Examiner	Art Unit

1791

SEARCHED				
Class	Subclass	Date	Examiner	
156	295, 87	10/28/2009	/JL/	
29	832, 840, 25.01	10/28/2009	/JL/	
438	118, 119	10/28/2009	/JL	
257	E21.505, E21.514	10/28/2009	/JL/	

JAEYUN LEE

SEARCH NOTES			
Search Notes	Date	Examiner	
East Search (USPGPUB, USPAT, USOCR, FPRS, EPO, JPO, Derwent,	10/28/2009	/JL/	
IBM_TDB) and text search			
Inventor Search (Edan)	10/28/2009	/JL/	
Consulted Primary Examiner (Jeff Aftergut)	10/28/2009	/JL/	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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